

P-Channel Enhancement Mode MOSFET

GENERAL DESCRIPTION

The PW3407 uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.

FEATURES

$V_{DS} = -30V, I_D = -4.2A$

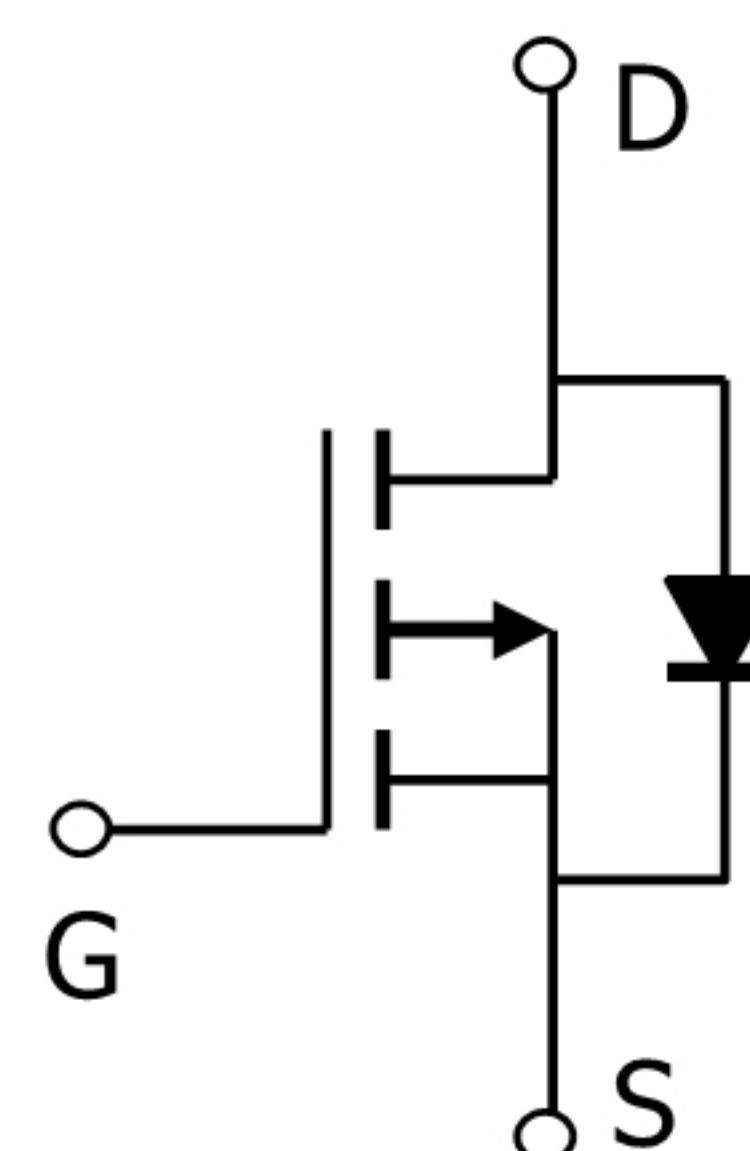
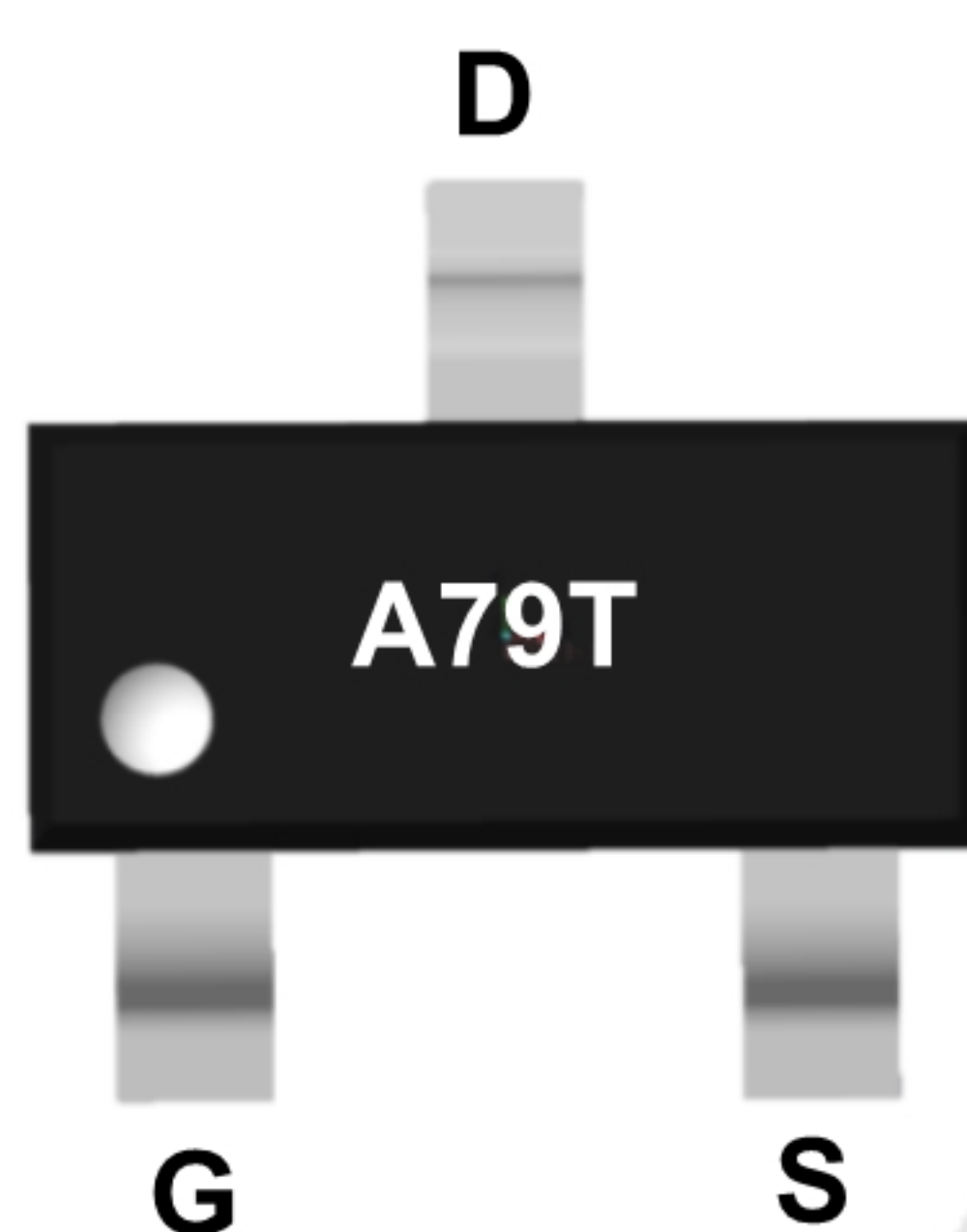
$R_{DS(ON)} < 65m\Omega$ @ $V_{GS} = -10V$

$R_{DS(ON)} < 90m\Omega$ @ $V_{GS} = -4.5V$

Available in a 3-Pin SOT23-3 Package



SOT-23-3L
(TOP VIEW)



Absolute Maximum Ratings (TA=25°C unless otherwise noted)

Symbol	Parameter	Rating	Units
V_{DS}	Drain-Source Voltage	-30	V
V_{GS}	Gate-Source Voltage	± 20	V
$I_D @ T_A = 25^\circ C$	Continuous Drain Current, V_{GS} @ -10V ¹	-4.2	A
$I_D @ T_A = 70^\circ C$	Continuous Drain Current, V_{GS} @ -10V ¹	-3.1	A
I_{DM}	Pulsed Drain Current ²	-17	A
$P_D @ T_A = 25^\circ C$	Total Power Dissipation ³	1.32	W
$P_D @ T_A = 70^\circ C$	Total Power Dissipation ³	0.84	W
T_{STG}	Storage Temperature Range	-55 to 150	°C
T_J	Operating Junction Temperature Range	-55 to 150	°C
$R_{\theta JA}$	Thermal Resistance Junction-Ambient ¹	125	°C/W
$R_{\theta JA}$	Thermal Resistance Junction-Ambient ¹ ($t \leq 10s$)	95	°C/W
$R_{\theta JC}$	Thermal Resistance Junction-Case ¹	80	°C/W

ELECTRICAL CHARACTERISTICS

(TA = 25°C, unless otherwise noted.)

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
BVDSS	Drain-Source Breakdown Voltage	$V_{GS}=0V$, $I_D=-250\mu A$	-30	-36	---	V
$\Delta BVDSS/\Delta T_J$	BV_{DSS} Temperature Coefficient	Reference to 25°C, $I_D=-1mA$	---	-0.023	---	V/°C
RDS(ON)	Static Drain-Source On-Resistance ²	$V_{GS}=-10V$, $I_D=-3A$	---	50	65	mΩ
		$V_{GS}=-4.5V$, $I_D=-2A$	---	65	90	
VGS(th)	Gate Threshold Voltage	$V_{GS}=V_{DS}$, $I_D=-250\mu A$	-1.2	-1.6	-2.5	V
$\Delta V_{GS(th)}$	$V_{GS(th)}$ Temperature Coefficient		---	4	---	mV/°C
IDSS	Drain-Source Leakage Current	$V_{DS}=-24V$, $V_{GS}=0V$, $T_J=25^\circ C$	---	---	-1	μA
		$V_{DS}=-24V$, $V_{GS}=0V$, $T_J=55^\circ C$	---	---	-5	
IGSS	Gate-Source Leakage Current	$V_{GS}=\pm 20V$, $V_{DS}=0V$	---	---	±100	nA
gfs	Forward Transconductance	$V_{DS}=-5V$, $I_D=-3A$	---	11	---	S
Qg	Total Gate Charge (-4.5V)	$V_{DS}=-15V$, $V_{GS}=-4.5V$, $I_D=-3A$	---	6.4	9.0	nC
Qgs	Gate-Source Charge		---	2.3	3.2	
Qgd	Gate-Drain Charge		---	1.9	2.7	
Td(on)	Turn-On Delay Time	$V_{DD}=-15V$, $V_{GS}=-10V$, $R_G=3.3\Omega$ $I_D=-3A$	---	2.8	5.6	ns
Tr	Rise Time		---	8.4	15.1	
Td(off)	Turn-Off Delay Time		---	39	78.0	
Tf	Fall Time		---	6	12.0	
Ciss	Input Capacitance	$V_{DS}=-15V$, $V_{GS}=0V$, $f=1MHz$	---	583	816	pF
Coss	Output Capacitance		---	100	140	
Crss	Reverse Transfer Capacitance		---	80	112	
Is	Continuous Source Current ^{1,4}	$V_G=V_D=0V$, Force Current	---	---	-3.3	A
ISM	Pulsed Source Current ^{2,4}		---	---	-17	A
VSD	Diode Forward Voltage ²	$V_{GS}=0V$, $I_S=-1A$, $T_J=25^\circ C$	---	---	-1	V
t _{rr}	Reverse Recovery Time	$I_F=-3A$, $dI/dt=100A/\mu s$, $T_J=25^\circ C$	---	7.8	---	nS
Q _{rr}	Reverse Recovery Charge		---	2.5	---	nC

Note : .

- 1、 The data tested by surface mounted on a 1 inch 2 FR-4 board with 2OZ copper.
- 2、 The data tested by pulsed , pulse width $\leq 300\mu s$, duty cycle $\leq 2\%$
- 3、 The power dissipation is limited by 150°C junction temperature
- 4、 The data is theoretically the same as ID and IDM , in real applications , should be limited by total power dissipation.

Typical Characteristics

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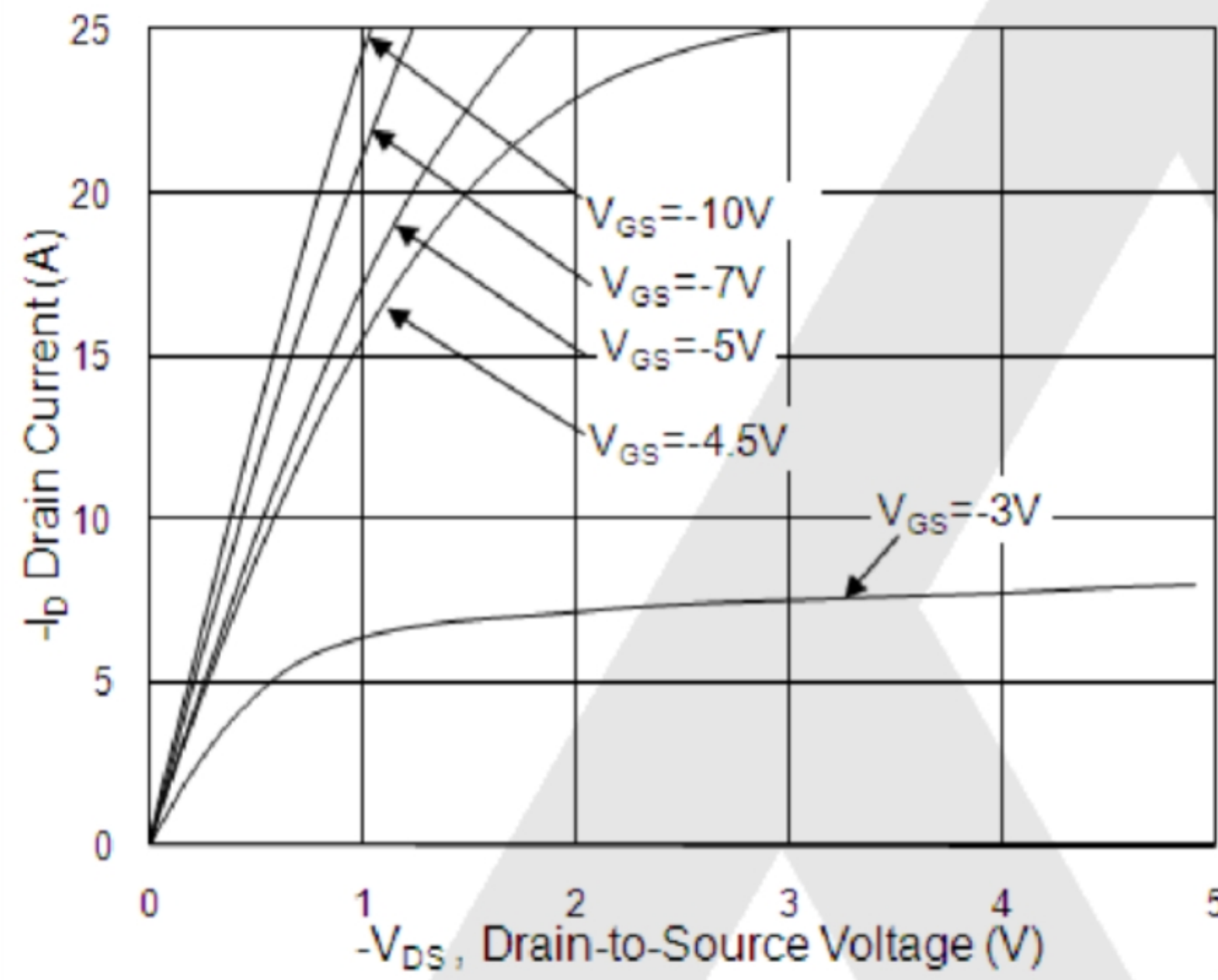


Fig.1 Typical Output Characteristics

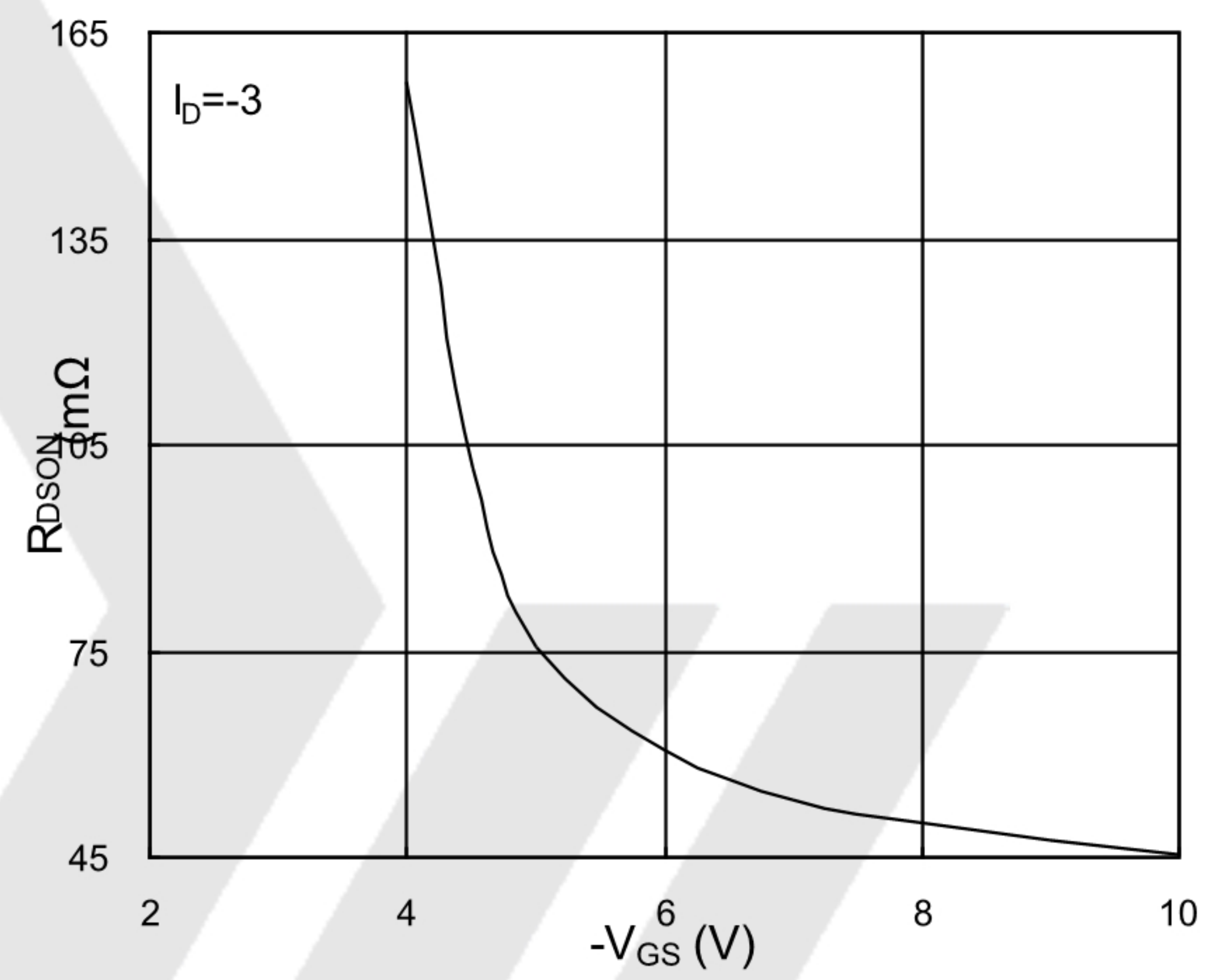


Fig.2 On-Resistance v.s Gate-Source

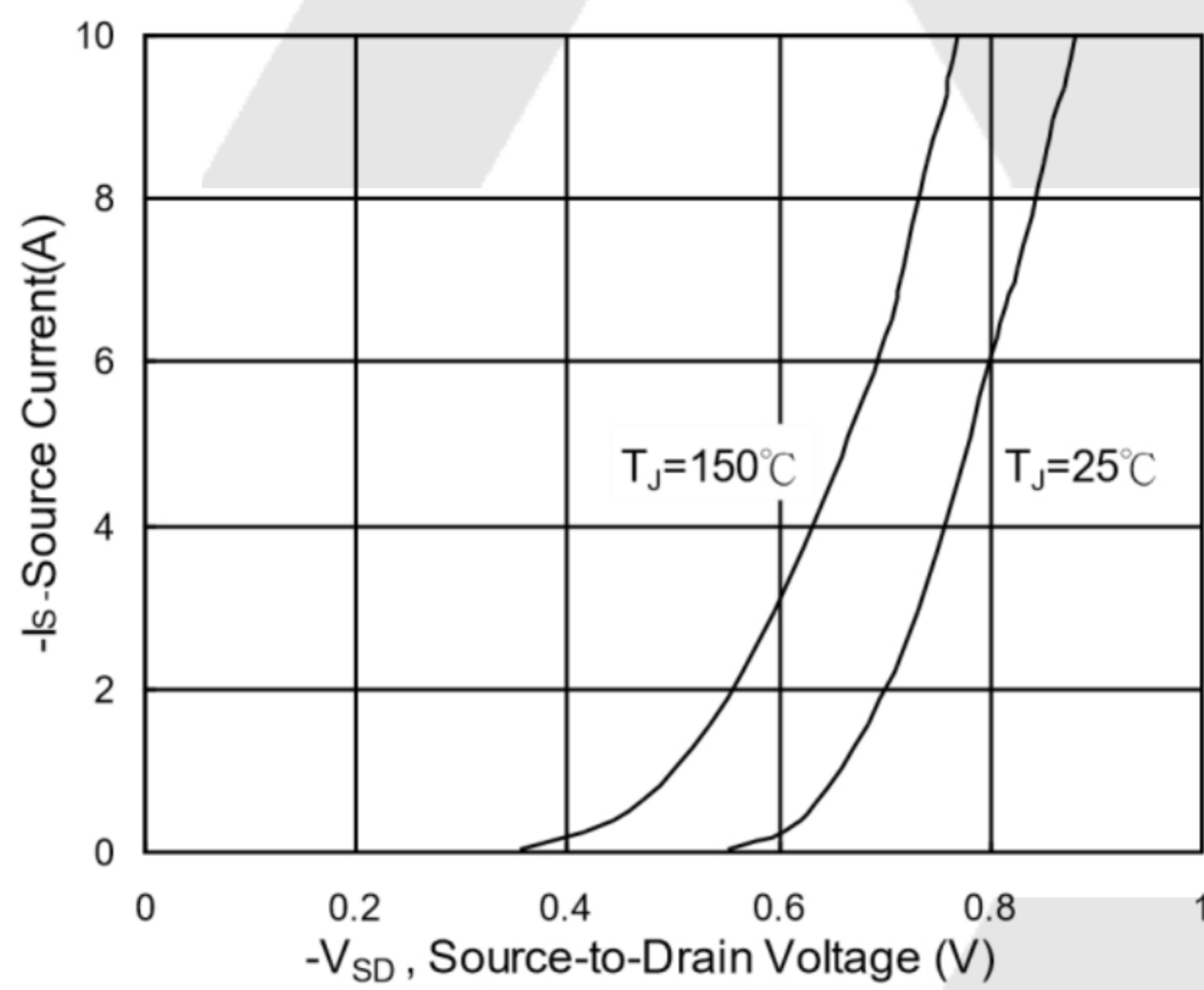


Fig.3 Forward Characteristics of Reverse

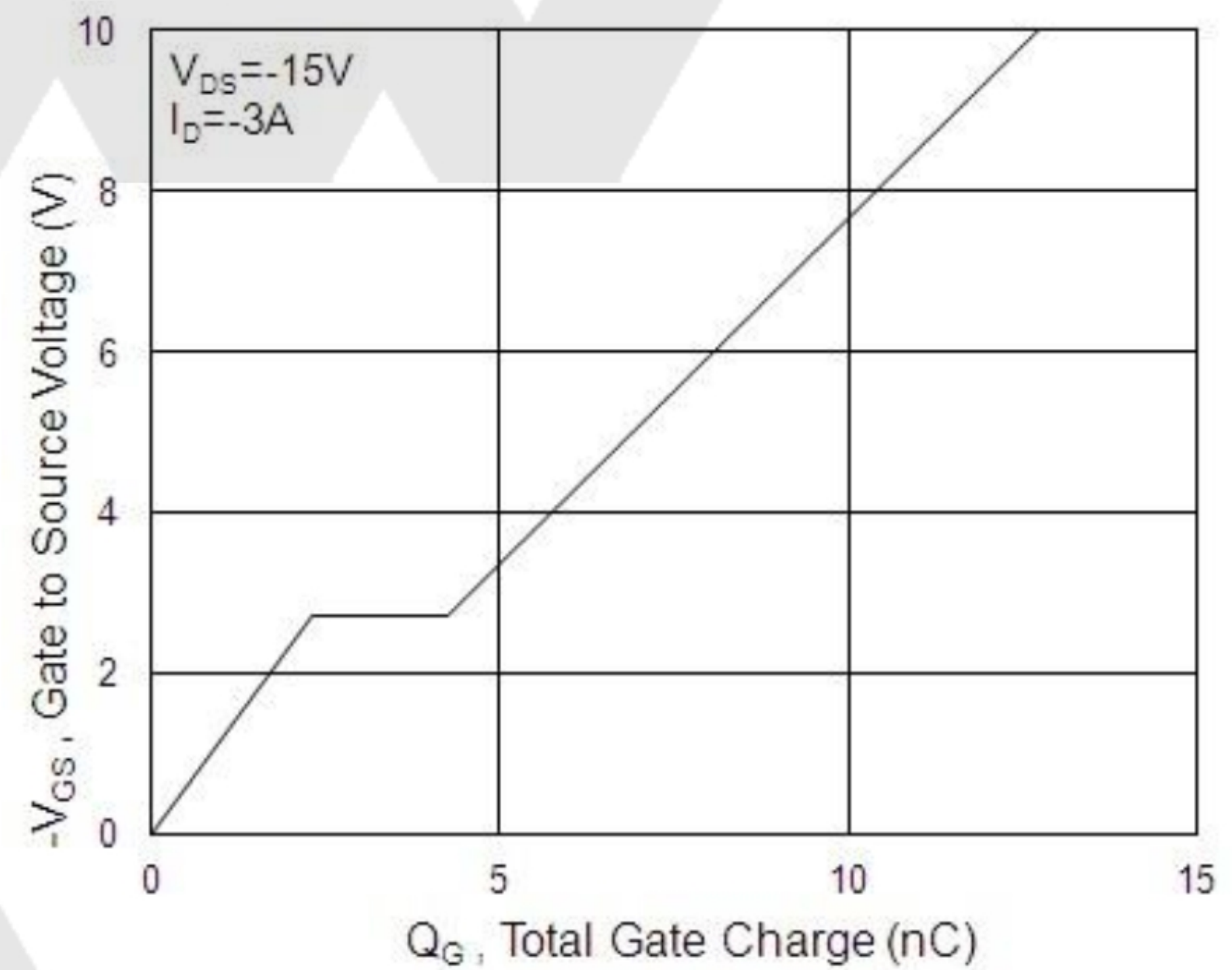


Fig.4 Gate-Charge Characteristics

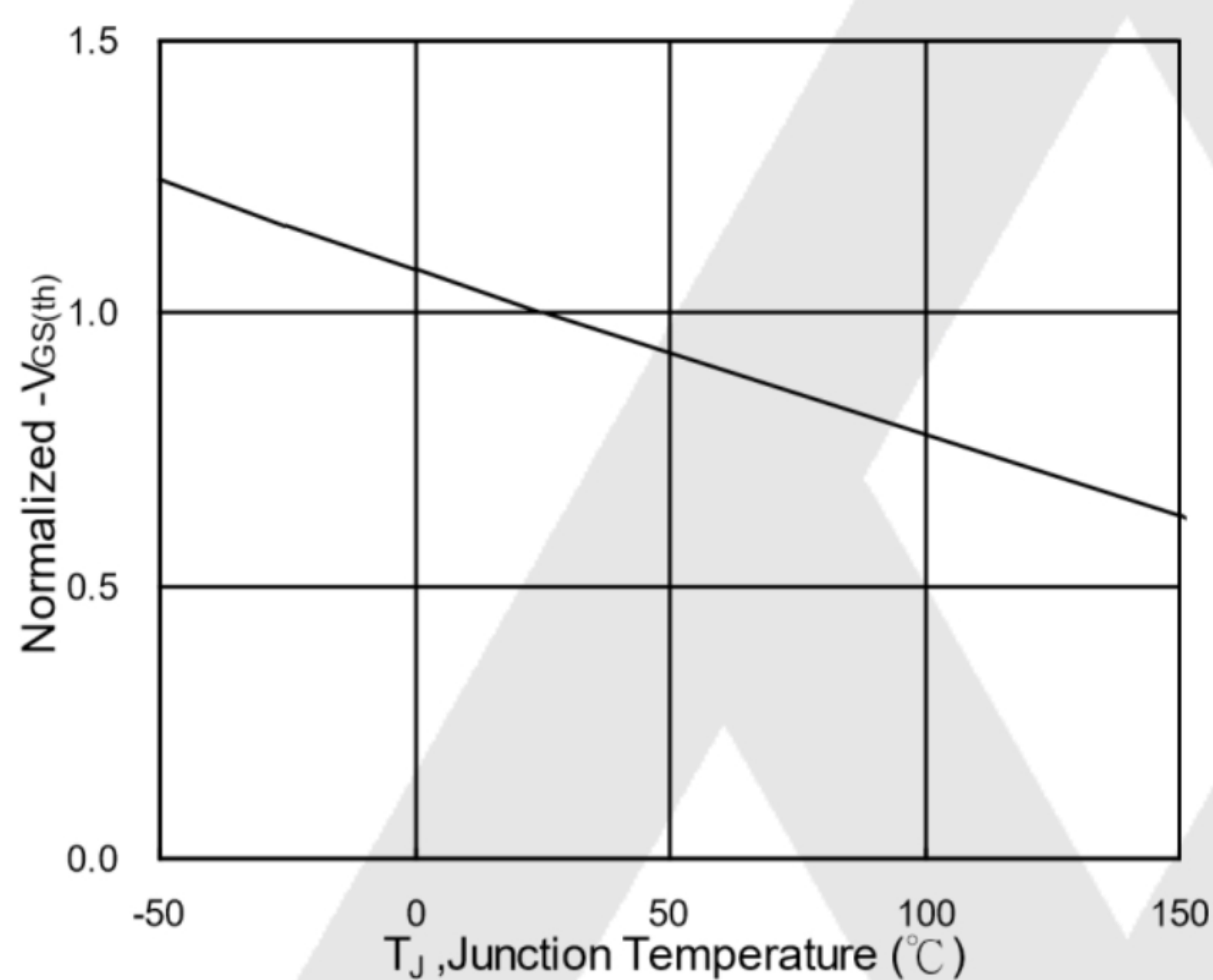


Fig.5 Normalized $V_{GS(th)}$ vs. T_J

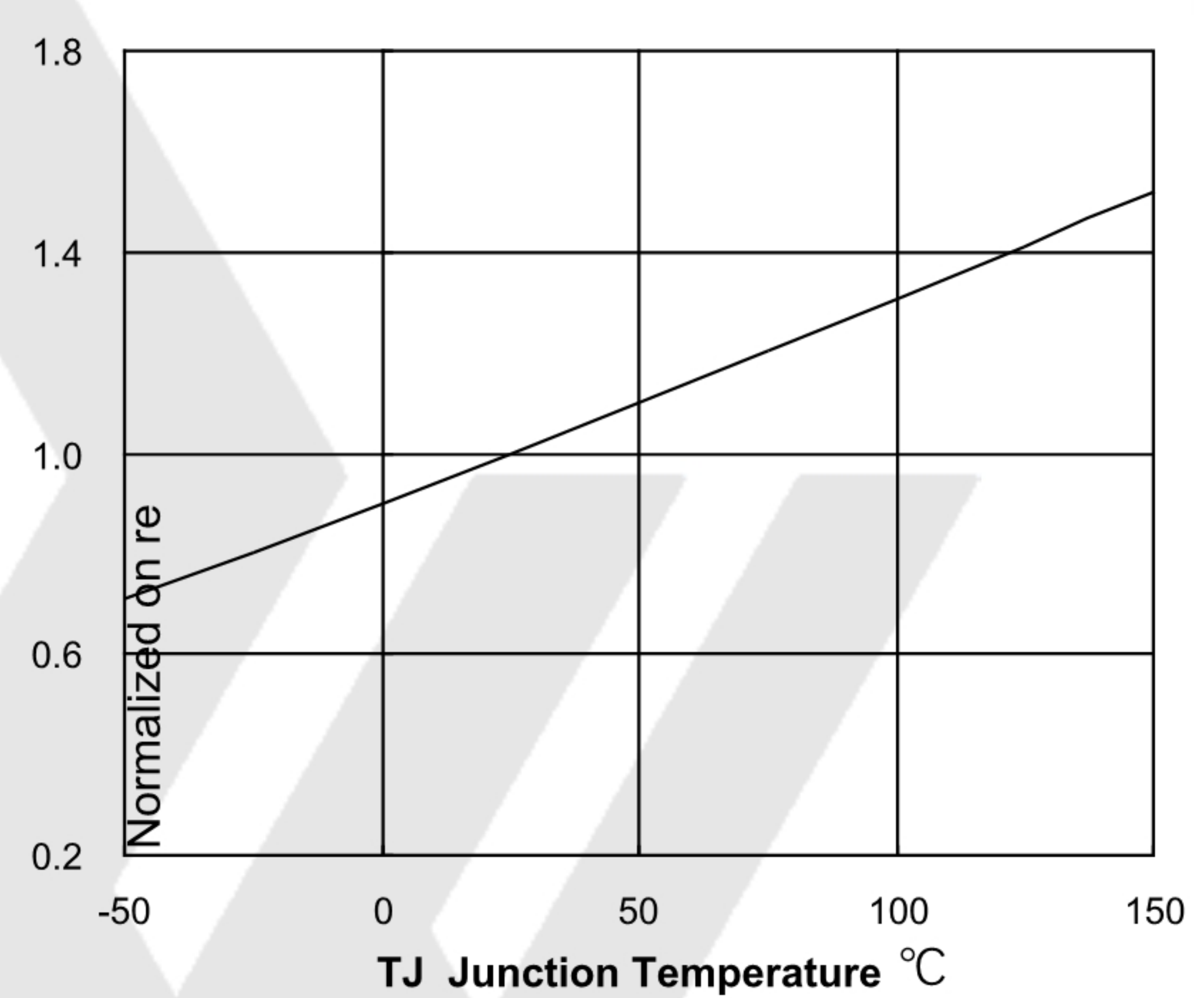


Fig.6 Normalized $R_{DS(on)}$ vs T_J

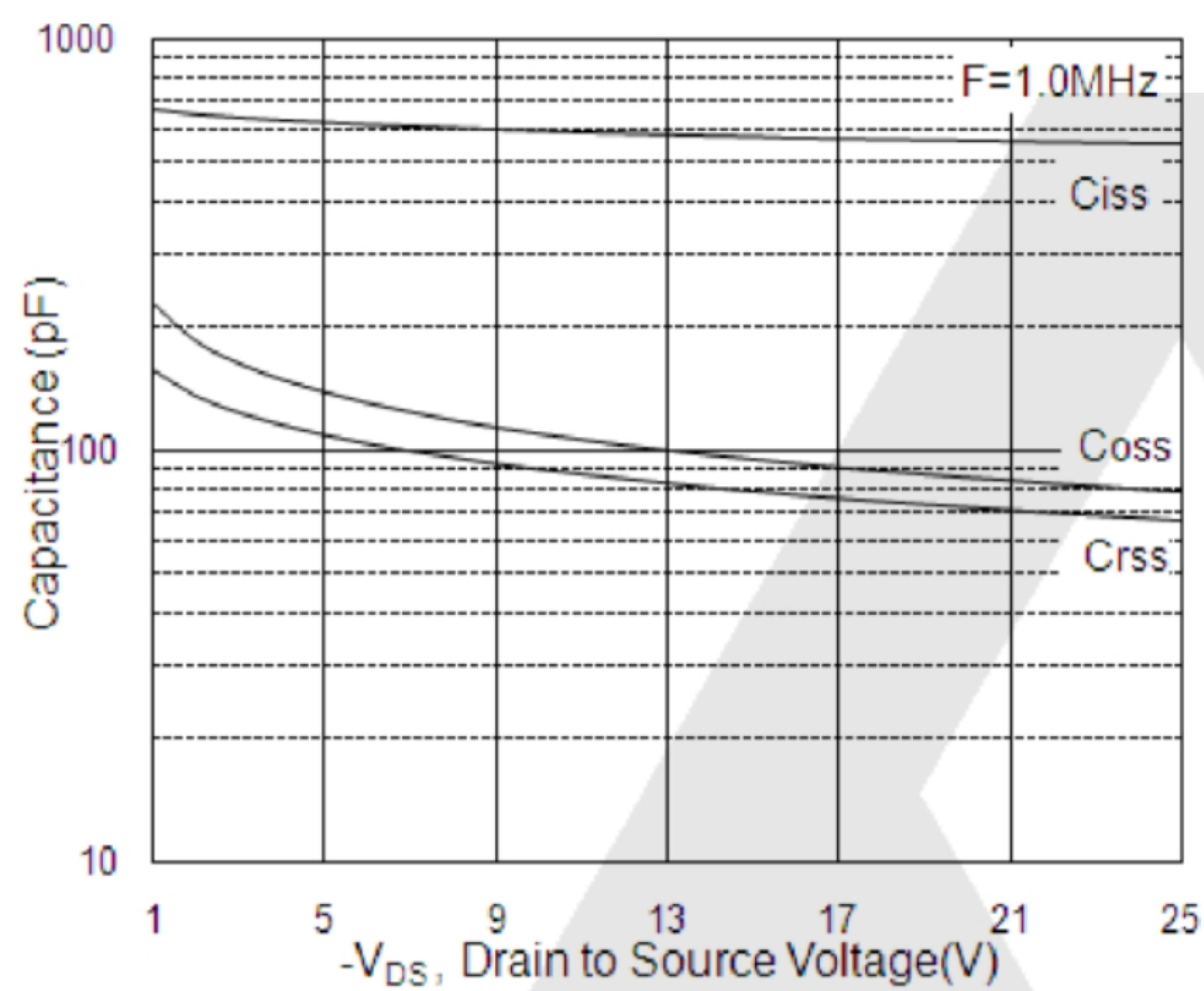


Fig.7 Capacitance

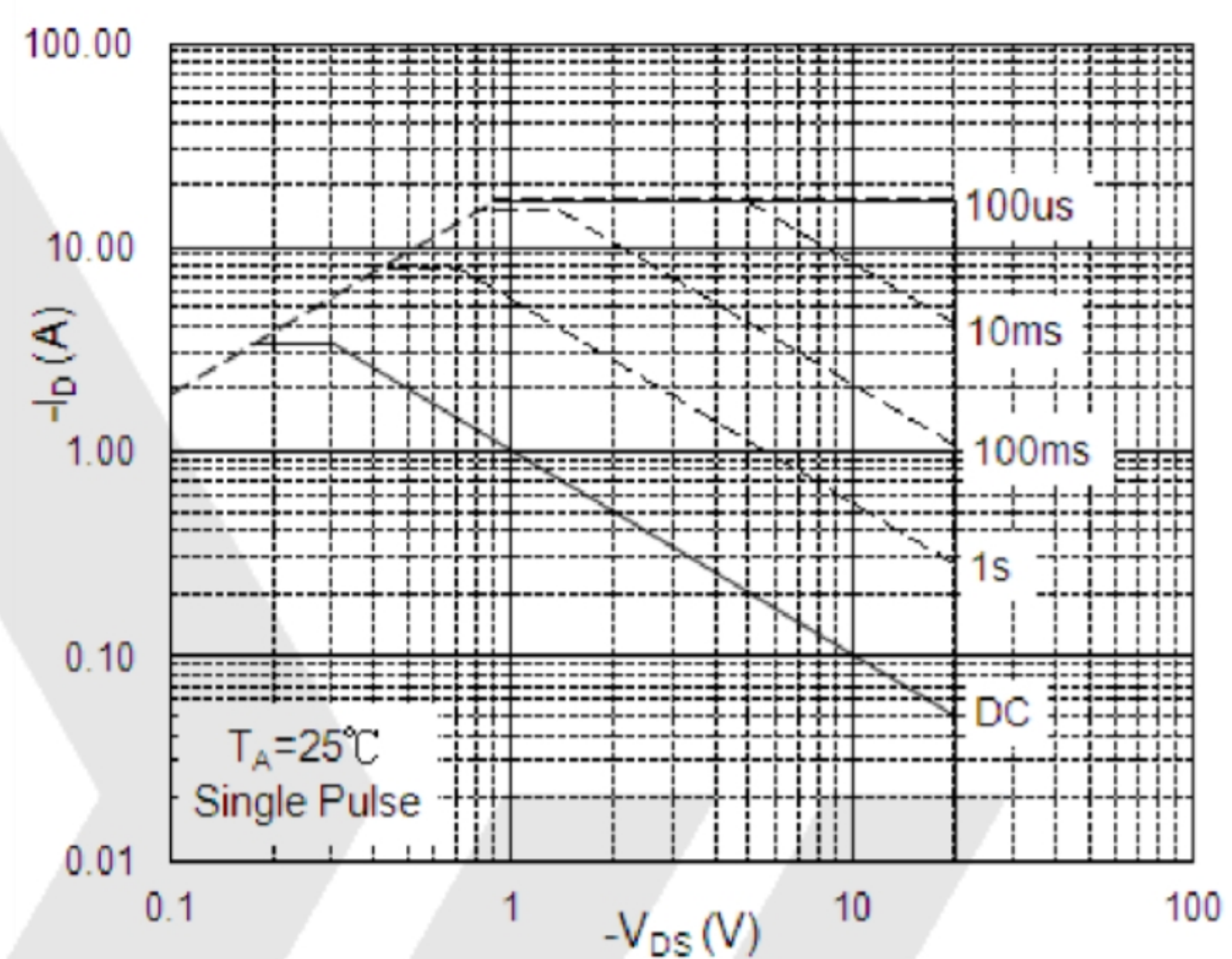


Fig.8 Safe Operating Area

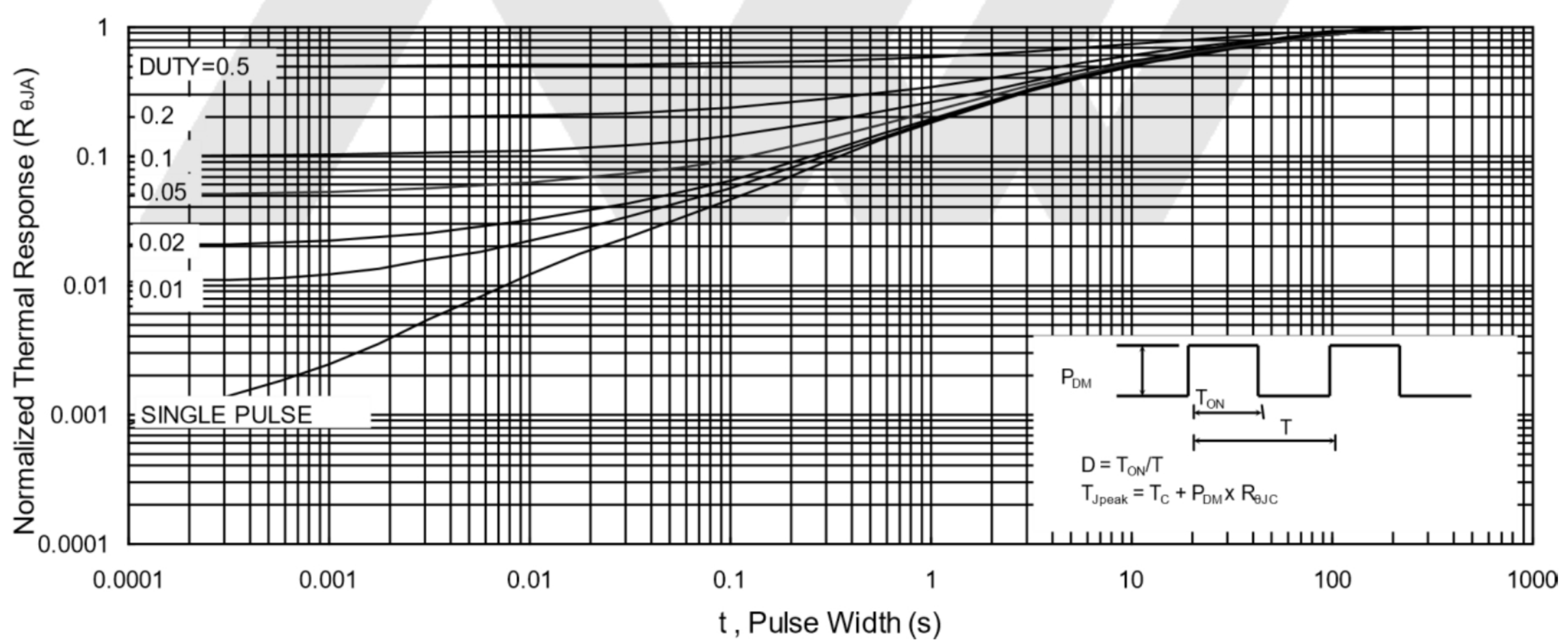


Fig.9 Normalized Maximum Transient Thermal Impedance

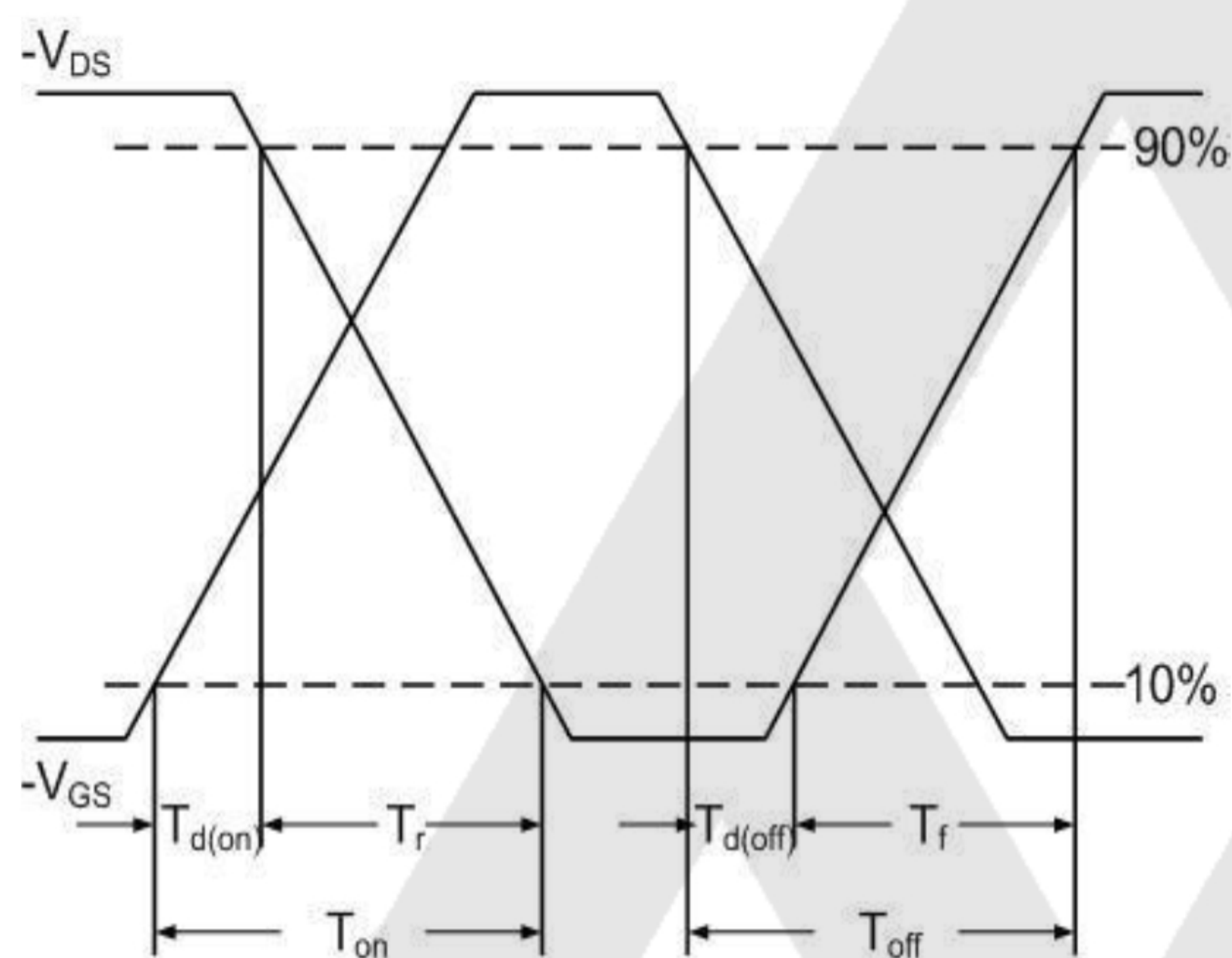


Fig.10 Switching Time Waveform

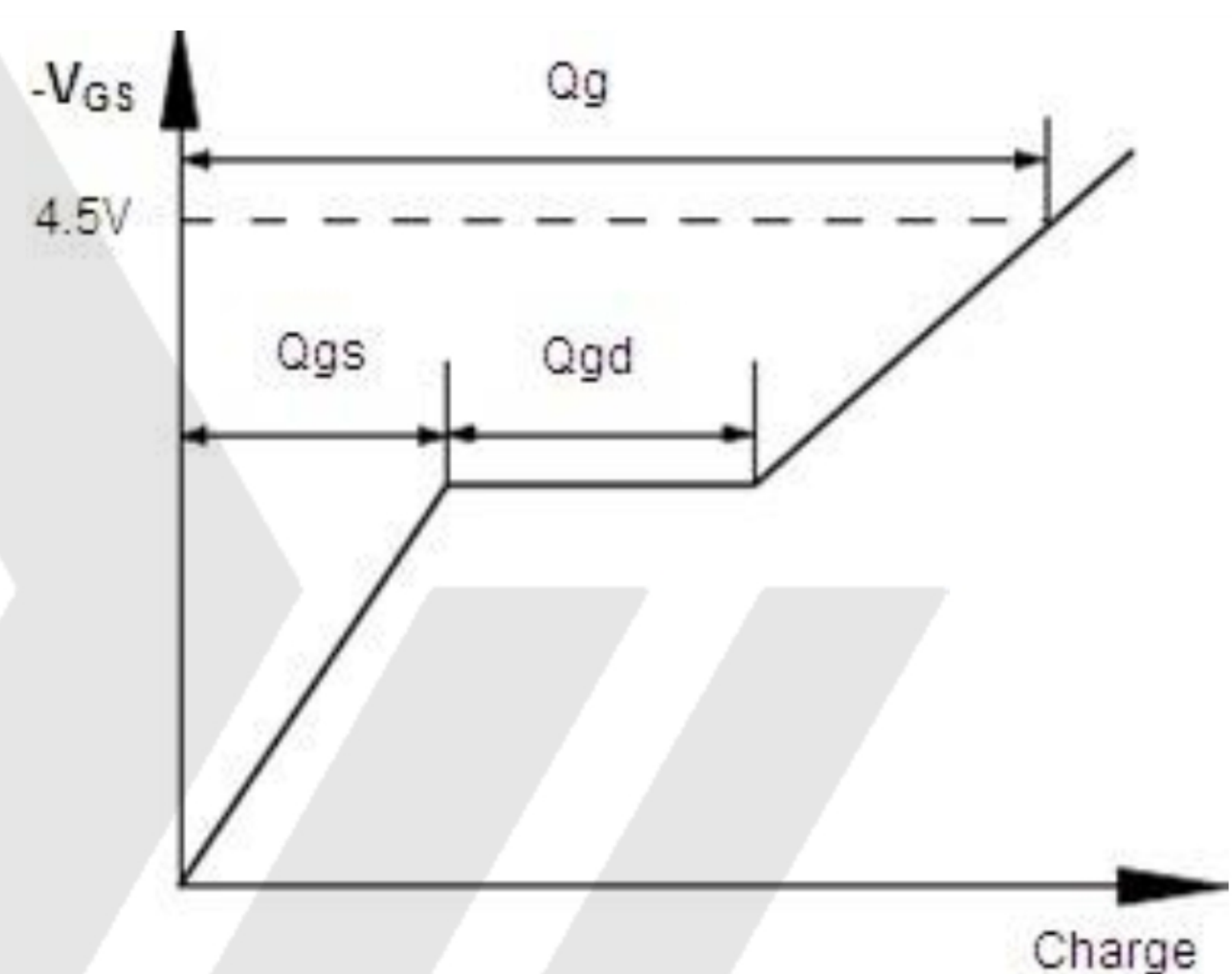
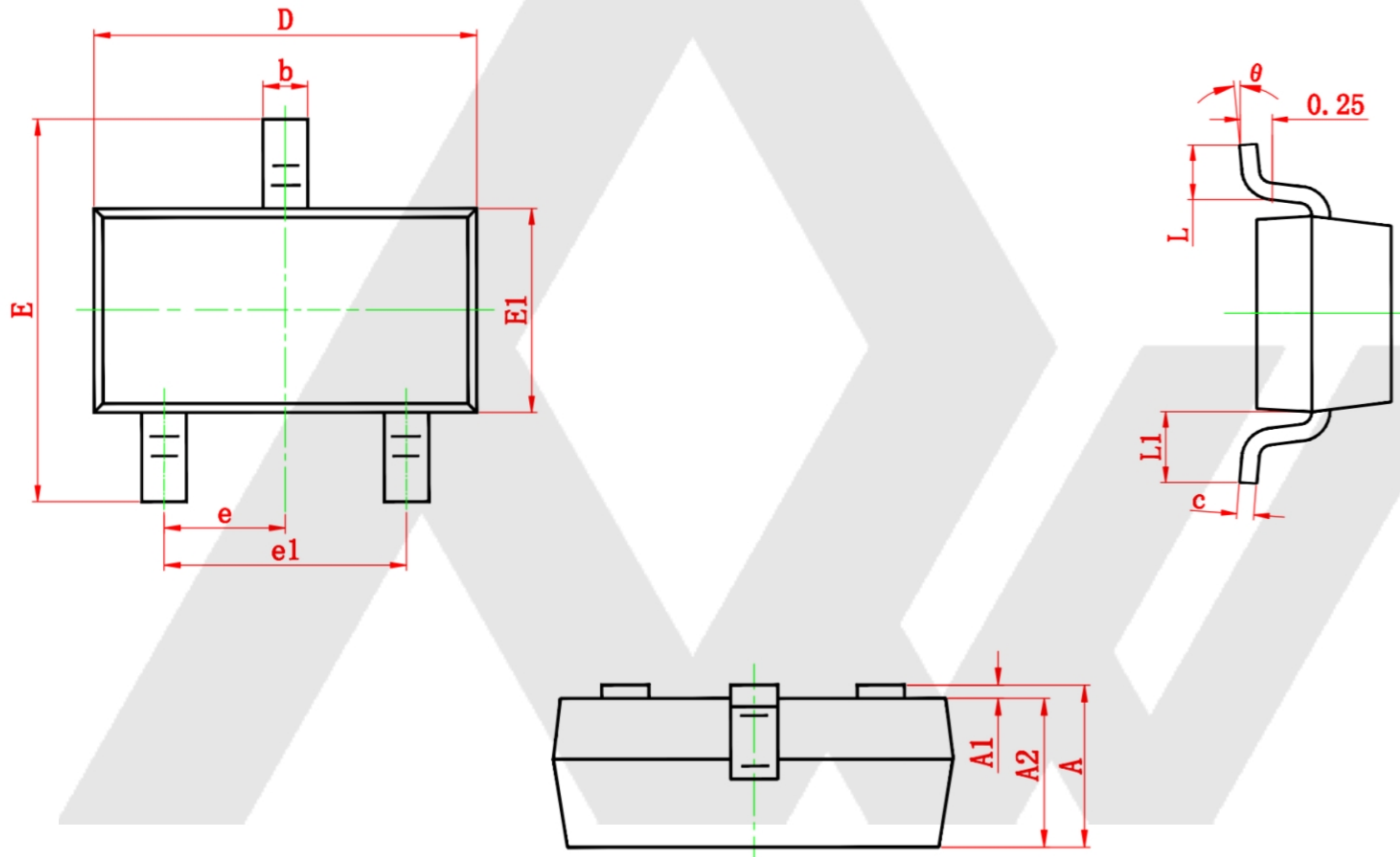


Fig.11 Gate Charge Waveform

PACKAGE DESCRIPTION

SOT23-3



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	0.900	1.150	0.035	0.045
A1	0.000	0.100	0.000	0.004
A2	0.900	1.050	0.035	0.041
b	0.300	0.500	0.012	0.020
c	0.080	0.150	0.003	0.006
D	2.800	3.000	0.110	0.118
E	2.250	2.550	0.089	0.100
E1	1.200	1.400	0.047	0.055
e	0.950 TYP.		0.037 TYP.	
e1	1.800	2.000	0.071	0.079
L	0.300	0.500	0.012	0.020
L1	0.550 REF.		0.022 REF.	
θ	0°	8°	0°	8°

Notes

1. All dimensions are in millimeters.
2. Tolerance $\pm 0.10\text{mm}$ (4 mil) unless otherwise specified
3. Package body sizes exclude mold flash and gate burrs. Mold flash at the non-lead sides should be less than 5 mils.
4. Dimension L is measured in gauge plane.
5. Controlling dimension is millimeter, converted inch dimensions are not necessarily exact.

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